

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1276	Scanning adj electron adj microscope?	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2004/12/27 14:05
L2	25492	Scanning adj electron adj microscope	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2004/12/27 14:06
L3	287	2 and (lens near4 wafer)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2004/12/27 14:07
L4	17	3 and (retarding near4 voltage)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2004/12/27 14:53
L5	21	3 and (automatic near4 focus\$3)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2004/12/27 14:40
L6	3	3 and (movable near4 holder)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	AND	ON	2004/12/27 15:10
L7	2370	((250/307,310,397,) or (345/771,))CCLS	USPAT	OR	OFF	2004/12/27 15:11
L8	604	7 and SEM	USPAT	OR	OFF	2004/12/27 15:12
L9	35	8 and (lens near4 wafer)	USPAT	OR	OFF	2004/12/27 15:12
L10	4	9 and (retarding near4 voltage)	USPAT	OR	OFF	2004/12/27 15:13

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